

Claims

What is claimed is:

1. A microelectronic package comprising:
a first level substrate including a plurality of microelectronic devices and a
5 plurality of first level substrate input/output pads in a face thereof;
a thin film decal on the face of the first level substrate, the thin film decal
including first and second opposing faces, a plurality of first decal input/output pads on
the first face, at least one of which is electrically connected to at least one of the first
level substrate input/output pads, a plurality of second decal input/output pads on the
10 second face and at least one internal wiring layer that is electrically connected to at least
one of the first and second decal input/output pads;
a second level substrate including a plurality of second level substrate
input/output pads on a face thereof; and
a dielectric adhesive layer that is adhesively bonded to the thin film decal and that
15 is adhesively boded to the second level substrate, the dielectric adhesive layer including a
plurality of conductive vias therein that electrically connect at least one of the second
level substrate input/output pads to at least one of the second decal input/output pads.
- 2 A microelectronic package according to Claim 1 wherein the conductive vias
20 comprise conductive adhesive vias.
3. A microelectronic package according to Claim 1 wherein the first level substrate
is an integrated circuit and wherein the second level substrate is a printed circuit board.
- 25 4. A microelectronic package according to Claim 2 wherein the conductive vias are
screened conductive adhesive vias.
5. A microelectronic package according to Claim 1 further comprising a stress buffer
layer in the dielectric adhesive layer.
- 30 6. A microelectronic package according to Claim 1 wherein the first face includes a
rippled surface.

7. A microelectronic package according to Claim 1 wherein the first face is substantially planar and topography-free.

8. A microelectronic package according to Claim 1 wherein the thin film decal and the dielectric adhesive layer collectively comprises a Planar Graft Patch that is grafted onto said second level substrate from a process substrate.

9. A microelectronic package comprising:
a substrate;
a release layer on the substrate;
a thin film decal on the release layer, opposite the substrate, the thin film decal including first and second opposing faces, a plurality of first decal input/output pads on the first face, and a plurality of second decal input/output pads in the second face and at least one internal wiring layer that is electrically connected to at least one of the first and second decal input/output pads; and
a dielectric adhesive layer that is adhesively bonded to the thin film decal, the dielectric adhesive layer including a plurality of conductive vias therein that electrically connect to at least one of the second decal input/output pads.

10. A microelectronic package according to Claim 9 wherein the conductive vias comprise conductive adhesive vias.

11. A microelectronic package according to Claim 9 wherein the substrate is a glass substrate.

12. A microelectronic package according to Claim 9 wherein the conductive vias are screened conductive adhesive vias.

13. A microelectronic package according to Claim 9 further comprising a stress buffer layer in the dielectric adhesive layer.

14. A microelectronic package according to Claim 9 wherein the first face includes a rippled surface.

15. A microelectronic package according to Claim 9 wherein the first face is substantially planar and topography-free.